EMI FILTER MCF18 (1608 (0603) size, 4A)

Features

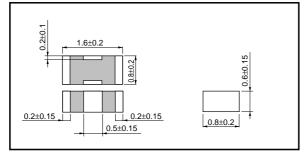
- 1) Industry's smallest size(1608 size)
- 2) The entire series is rated at 4A, making them ideal for high current circuits in or around the power supply.
- 3) The internal resistance is lower than in standard products (competitors' 2A units)

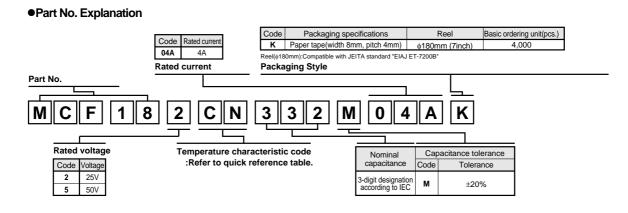
•Quick Reference

The design and specifications are subject to change without prior notice. Please check the most recent technical specifications prior to placing orders or using the product. For more detail information regarding packaging style code, please check product designation.

Part No.	Model Name	Capacitance (pF)	Capacitance tolerance (%)	Temperatu code	re characteristics	Rated voltage (V)	Rated current (A/DC)	Insulation resistance(MΩ)	Operating temperature(°C)	Thickness (mm)
	MCF185AN100M04AK	10		AN	0±30 ppm/°C	50	4	1000	-55 to +125	0.6
	MCF185AN220M04AK	22	1							
	MCF185AN470M04AK	47	1							
	MCF185AN101M04AK	100	M (±20)							
	MCF185AN221M04AK	220								
	MCF185AN471M04AK	470								
MCF18	MCF182CN102M04AK	1000		CN	Rate of capacitance change ±15%	25				
	MCF182CN222M04AK	2200								
	MCF182CN332M04AK	3300								
	MCF182CN472M04AK	4700								
	MCF182CN103M04AK	10000								
	MCF182CN223M04AK	22000								
	MCF182CN473M04AK	47000								

• Dimensions (Unit : mm)





•Performance and test method

No.	Items		Performance		Test Method		
1	Appearance and dimensions	No mark for appe	ed defects shall be allowed arance.	Using a Magnifier.			
2	Withstanding voltage		ctrical breakdown or other shall be allowed.	Charac- teristic AN CN Voltage shall b	e applied as per Table1. Table 1 Voltage 300% Rated voltage 250% Rated voltage e applied for 1 to 5s with and discharging current.		
3	Insulation resistance		than 1000M Ω or μ F, whichever is less.		shall be made after of the rated voltage		
4	Capacitance		ance shall be vecified tolerance range.		shall be made under the cified in Table 2. Table 2 Frequency • Voltage 1+/-0.1MHz 1+/-0.1Vrms. 1+/-0.1kHz 1+/-0.1Vrms.		
5	Dielectric loss tangent	AN CN	Capacitance < $30pF$ tan $\delta \le 100/(400+20C)\%$ Capacitance $\ge 30pF$ tan $\delta \le 0.1\%$ tan $\delta \le 3.0\%$	1	s shall be made under the cified in Table 2.		
6	Resistance	Within sp Rated current 4A	between①-② between③-④ terminal resistance terminal resistance 20mΩMax. 2000mΩMax.	Measurement	current 100mA max 3 2 T 4 L T		

No.	lte	ms		Performance	Test Method		
7	Temperature characteristic	Without voltage application	AN CN	0+/-30ppm / °C (-55°C to +125°C) +/-15% (-55°C to +125°C)	If required measurements shall be made at a given temperature.		
8	8 Solderability		More than 75% of each end termination shall be covered with new solder.		The solder specified in SnAg3.0Cu0.5 shall be used. And the flux containing 25% rosin and ethanol solution shall be used. The specimens shall be immersed into the solder at $235+/-5^{\circ}$ C for $2+/-0.5$ S So that both end terminations are completely under solder.		
9	Resistance to solderin heat	Appearance	Without mechanical damage.		The solder specified in SnAg3.0Cu0.5 shall be used. The specimens shall be immersed into the solder at $260+/-5^{\circ}C$ for $5+/-0.5s$ so that		
		Change rate from initial value	AN	Within +/-2.5%	both end terminations are completely under the solder. Pre-heating at 150+/-10°C for 1 to 2min		
			CN	Within +/-7.5%	Initial measurements prior to test shall be performed after the thermal Pre-conditioning specified in Remarks (1). Final measurements shall be made after the specimens have been left at room		
		Dielectric loss tangent	Within spe	cified initial value.			
		Insulation resistance	Within specified initial value.		- temperature as per Table3. Table3 Charac- teristic AN 24+/-2 h CN 48+/-4 h		
					CN 48+/-4 n		
10	End termination adherence		Without peeling or sign of peeling shall be allowed on the end terminations.		A 5N weight for 10+/-1s shall be applied to the soldered specimens as shown by the arrow mark in the below sketch.		

No.	lte	ems		Performance	Test Method				
11	Bending strength	Appearance	Without r	nechanical damage.	Glass epoxy board with soldered specimens shall be bent till 1mm by 1.0mm/s.				
12	Vibration	Appearance	Without r	nechanical damage.	The specimens shall be soldered on the specified test jig.				
		Change rate from initial value	AN	Within +/-2.5%	Initial measurements shall be made after the thermal pre-conditioning specified in Remarks(1).				
			CN	Within +/-7.5%	Final measurements shall be made after th specimens have been left at room temperature as per Table3.				
		Dielectric loss tangent	Within specified initial value.		[Condition] Directions : 2h each in X, Y and Z direction Total : 6h Frequency range : 10 to 55 to 10Hz(1min) Applitude : 1.5mm (shall not exceed acceleration196m/s ²)				
					Table3				
					Charac- teristic Time				
					AN 24+/-2 h				
					CN 48+/-4 h				
13	Temperature cycling	Appearance	Without r	nechanical damage.	The specimens shall be soldered on the te jig shown in Remarks.				
		Change rate from initial value Dielectric loss tangent	AN	Within +/-2.5%	Temperature cycle : 100cycles Initial measurements prior to test shall be performed after the thermal per-conditioning specified in Remarks (
			CN	Within +/-7.5%	Final measurements shall be made after th specimens have been left at room temperature as per Table3.				
			Within sp	ecified initial value.	Step Temp. (°C) Time (min) 1 Min operating temp.+/-3 30+/-3				
		Insulation	Within sp	ecified initial value.	$\begin{array}{c c} 2 & \text{Room temp.} & \leq 3 \end{array}$				
		resistance			3 Max operating temp.+/-3 30+/-3				
					$4 \text{Room temp.} \leq 3$				
					Table3				
					Charac- teristic				
					AN 24+/-2 h				
					CN 48+/-4 h				

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No.	lte	ms	Performance		Test Method			
14	Humidity	Appearance	Without me	chanical damage.	Test temperature : 60+/-2°C			
	(Steady)	Change rate from initial value	AN	Within +/-5.0%	Relative humidity : 90 to 95% Test time : 500 +24/–0 h Initial measurements prior to test shall be made after the voltage			
			CN	Within +/-12.5%	pre-conditioning specified in Remarks (2).			
		Dielectric tangent	AN	tan $\delta \le 0.3\%$	Final measurements have been left at room temperature as per Table3.			
			CN	tan $\delta \le 200\%$ initial spec.	Table3			
		Insulation resistance		n 500M Ω or whichever is less.	Charac- teristic Time			
					AN 24+/–2 h CN 48+/–4 h			
15	Humidity life test	Appearance	Without me	chanical damage.	Test temperature : 60+/-2°C			
		Change rate from initial value	AN	Within +/-7.5%	Relative humidity : 90 to 95% Voltage : Rated voltage Test time : 500 +24/–0 h Initial measurements prior to test shall			
			CN	Within +/-12.5%	be made after the voltage pre-conditioning specified in			
		Dielectric loss tangent	AN	tan δ≤ 0.5%	Remarks (2). Final measurements shall be made after the specimens have been left at room			
			CN	tan $\delta \leq$ 200% initial spec.	temperature as per Table3.			
		Insulation resistance		n 500MΩ or whichever is less.	Table3			
					Charac- teristic Time			
					AN 24+/-2 h			
					CN 48+/-4 h			

No.	Items			Performance		Test Method		
16	Heat life test	Appearance	Without mechanical damage.		Test temperature : 125+/-2°C			
		Change rate from initial value Dielectric loss tangent Insulation resistance	AN	Within +/-3.0%	Voltage : Reated voltage x 200% Test time : 1000 +48/–0 h Initial measurements prior to test shall be made after the voltage pre-conditioning specified in Remarks (2). Final measurements shall be made after			
			CN	Within +/-15%				after
			AN	tan δ ≤ 0.3%		the specimens have been left at room temperature as per Table3.		
			CN	tan δ≤ 200%	Table3			
				initial spec.		Charac- teristic	Time	
			Not less than $1000M\Omega$ o			AN	24+/2 h	
			$50M\Omega \cdot \mu F$, whichever is less.			CN	48+/-4 h	_

[Remarks]

Pre-conditioning

If specified in test method of as per 3(Performance and test method), capacitors of CN, characteristics shall be pre-conditionded as follows.

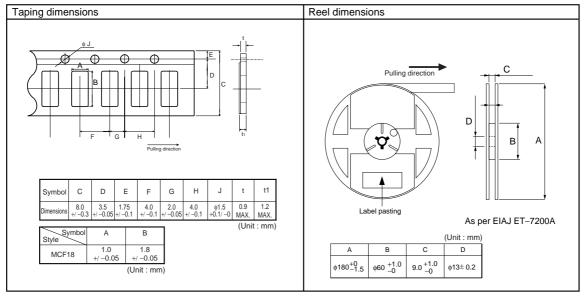
(1) Thermal pre-conditioning

Prior to initial measurements, specimens shall be conditioned at a temperature of 150 $0/-10^{\circ}$ C for a period of 1hr., and shall be allowed to stabilize at room temperature for 48+/-4h

(2) Voltage pre-conditioning

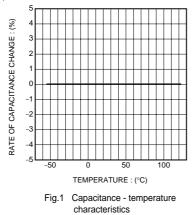
Prior to initial measurements, voltage specified as a test condition shall be applied to specimens for a period of 1hr., and the specimens shall be allowed to stabilize at room temperature for 48+/-4h

Packaging specifications

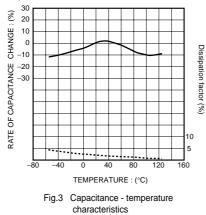


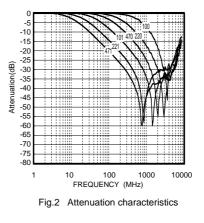
•Electrical characteristics

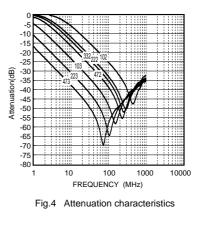
■ A (C0G) Characteristics











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Appendix1-Rev2.0

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